

FORM PTO-1449(Modified)

ATTY. DOCKET NO. A1-02US2

SERIAL NO.: 10/034,620

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S
INFORMATION DISCLOSURE STATEMENT

APPLICANT: James W. Overbeck

FILING DATE: December 27, 2001

GROUP: 2872

U.S. PATENT DOCUMENTS

Exam Init	Ref Des	Document No.	Date	Name	Class	Sub Class	FILING DATE If Appropriate
NG7		3,013,467	12/1961	Minsky	88	14	
NG7		3,588,218	06/1971	Hunt et al.	—	—	
NG7		3,643,015	01/1972	Davidovits et al.	178	6.8	
NG7		3,704,372	11/1972	Parker et al.	—	—	
NG7		3,879,615	04/1975	Moser	—	—	
NG7		3,891,299	06/1975	Rushing	350 359	8 196	
NG7		3,952,217	04/1976	Rawlings	310	36	
NG7		3,967,114	06/1976	Cornillault	—	—	
NG7		4,087,685	05/1978	Froot	250	302	
NG7		4,168,126	09/1979	Altman et al.	356	386	
NG7		4,289,371	09/1981	Kramer	—	—	
NG7		4,301,374	11/1981	Hashiue	—	—	
NG7		4,322,063	03/1982	Fishbeck et al.	267	160	
NG7		4,323,307	04/1982	Seeley	355	51	
NG7		4,379,624	04/1983	Miller et al.	—	—	
NG7		4,413,180	11/1983	Libby	—	—	
NG7		4,525,030	06/1985	Montagu et al.	350 359	255 196	
NG7		4,532,426	07/1985	Reeds	250	442.1	
NG7		4,567,585	1/1986	Gelbart	369	97	
NG7		4,611,881	09/1986	Schmidt et al.	—	—	
NG7		4,631,581	12/1986	Carlsson	—	—	
NG7		4,684,797	08/1987	Ando et al.	—	—	
NG7		4,712,887	12/1987	Baer	—	—	
NG7		4,718,050	01/1988	Kurz et al.	369	44.16	
NG7		4,761,774	08/1988	Ishibashi et al.	369	44.19	
NG7		4,784,481	11/1988	Wuerfel	350	529	
NG7		4,861,144	08/1989	Russell	350 359	412 368	
NG7		4,877,966	10/1989	Tomei et al.	—	—	
NG7		4,881,812	11/1989	Ohkubo et al.	356	344	
NG7		4,886,968	12/1989	Ohnishi	—	—	
NG7		4,995,711	02/1991	Imai et al.	350 359	529 368	
NG7		5,001,694	03/1991	Lee et al.	—	—	
NG7		5,029,955	07/1991	Chu	—	—	
NG7		5,074,628	12/1991	Khattak et al.	359	205	
NG7		5,088,079	02/1992	Baer	—	—	

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FORM PTO-1449(Modified)	ATTY. DOCKET NO. A1-02US2	SERIAL NO.: 10/034,620
	APPLICANT: James Overbeck et al	
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U.S. PATENT DOCUMENTS/CONTINUED

Exam Init	Ref Des	Document No.	Date	Name	Class	Sub Class	FILING DATE If Appropriate
NG		5,091,652	02/1992	Mathies et al.			
NG		5,143,854	09/1992	Pirung et al.	436	518	
NG		5,171,984	12/1992	van Rosmalen	250	236	
NG		5,193,013	03/1993	Swanberg	358	481	
NG		5,195,074	03/1993	Tanoshima et al.			
NG		5,216,247	06/1993	Wang et al.			
NG		5,224,088	06/1993	Atiya			
NG		5,274,240	12/1993	Mathies et al.			
NG		5,293,363	03/1994	Takeshita			
NG		5,315,375	05/1994	Allen	356	417	
NG		5,381,224	01/1995	Dixon et al			
NG		5,424,841	06/1995	Van Gelder et al.	356	417	
NG		5,436,718	07/1995	Fernandes et al.	356	73	
NG		5,459,325	10/1995	Hueton et al.			
NG		5,528,050	06/1996	Miller et al.			
NG		5,535,040	07/1996	Ohtsuka et al.	359	210	
NG		5,552,928	09/1996	Furuhashi et al.	359	379	
NG		5,578,818	11/1996	Kain et al.			
NG		5,578,832	11/1996	Trulson et al			
NG		5,585,639	12/1996	Dorsel et al.	250	458.1	
NG		5,610,754	03/1997	Ghee et al.			
NG		5,631,734	05/1997	Stern et al			
NG		5,646,411	07/1997	Kain et al			
NG		5,650,614	07/1997	Yasutake et al.	250	234	
NG		5,672,880	09/1997	Kain			
NG		5,719,391	02/1998	Kain	250	235	
NG		5,737,121	04/1998	Dixon			
NG		5,760,951	06/1998	Dixon et al			
NG		5,800,992	09/1998	Fodor et al.			
NG		5,880,465	03/1999	Boettner et al.	250	234	
NG		5,895,915	04/1999	DeWeerd et al.	250	234	
NG		6,185,030	02/2001	Overbeck			
NG		6,027,960	03/2001	Stern	250	458.1	
NG							

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FOREIGN PATENT DOCUMENTS

	Country & Doc. No. (11)	Pub. Date (43)	Class	Sub Class	Translation Yes	No
NE7	DE 40 20 527	01/1992	—	—		✓
NE7	EP 0 277 675	08/1988	—	—		✓
NE7	WO 88/02846	04/1988	—	—		✓
NE7	WO 96/18205	06/1996	—	—		✓
NE7	WO 96/30662	11/1996	—	—		✓
NE7	WO 97/28439	08/1997	—	—		✓

OTHER ART

(Including Author, Title, Date, Pertinent Pages, Publication, Etc.)

NE7	Beiser, Leo, "Laser Scanning and Recording: Developments and Trends", <i>Laser Focus</i> , (1985)
NE7	Castellino, Alexander M., "When the Chips are Down", <i>Genome Research</i> , vol. 7, No. 10, (1997)
NE7	White, D.L., "Soft X-ray Projection Lithography", <i>Solid State Technology</i> , (1991)
NE7	"The Infrared Handbook", <i>The Infrared Information Analysis (IRIA) Center</i> , 1989
NE7	Alexay et al., "Fluorescence Scanner Employing a Macro Scanning Objective", <i>SPIE</i> , vol. 2705
NE7	Benschop, J.P.H., "Miniature Scanning Optical Microscope Based on Compact Disc Technology", <i>Optical Storage and Scanning Technology</i> , vol. 1139, (1989)
NE7	Hamilton, D.K., "Scanning Optical Microscopy of Objective Lens Scanning", <i>Journal of Physics E: Scientific Instruments</i> , vol. 19, (1986)
NE7	Hanzel et al., "Investigation of a Microscanning Technology for the interrogation of Histological Samples", <i>Molecular Dynamics</i> , (1997)
NE7	Ishibashi, H., "High Speed accessing Magneto-Optical Disk Drive", <i>Optical Storage Technology and Application</i> , vol. 19, (1986)
NE7	Towner, David K., "Scanning Techniques for Optical data Storage", <i>Society of Photo-Optical Instrumentation Engineers</i> , vol. 695, (1986)
NE7	Yak, A.S., "High Speed Swing Arm Three Beam Optical Head", <i>Optical Storage Technologies</i> , vol. 1401, (1990)
NE7	Benschop et al., "Confocal compact scanning optical microscope based on compact disc technology" <i>Applied Optics</i> , vol. 30, No. 10 (1991); pp 119-1184

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(Including Author, Title, Date, Pertinent Pages, Publication, Etc.)

W-9			Dixon et al., "Confocal Scanning Beam Laser Microscope/Macroscopic", <i>IS&T/SPIE Symposium on Electronic Imaging Science and Technology</i> , (1995); pp 1-10
W-9			Montagu et al., "Fluorescence Array Scanner"; (1999); pp 1-9
W-9			Kramer et al., "Hologon Laser Scanners Not Just for Bar-Code Readers Anymore", <i>Photonics Spectra</i> , (1985); pp. 89-92
W-9			Beiser, Leo, "Scanning and Recording: Developments and Trends", <i>Laser Focus</i> , (1985)
W-9			Courtney-Pratt et al., "Microscope with Enhanced Depth of Field and 3-D Capability", <i>Applied Optics</i> , vol. 12, No. 10 (1973); pp. 2509-2519

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